

## CMOS Counter/Dividers

CD4017BMS - Decade Counter with 10 Decoded Outputs

CD4022BMS - Octal Counter with 8 Decoded Outputs

CD4017BMS and CD4022BMS are 5-stage and 4-stage Johnson counters having 10 and 8 decoded outputs, respectively. Inputs include a CLOCK, a RESET, and a CLOCK INHIBIT signal. Schmitt trigger action in the CLOCK input circuit provides pulse shaping that allows unlimited clock input pulse rise and fall times.

These counters are advanced one count at the positive clock signal transition if the CLOCK INHIBIT signal is low. Counter advancement via the clock line is inhibited when the CLOCK INHIBIT signal is high. A high RESET signal clears the counter to its zero count. Use of the Johnson counter configuration permits high speed operation, 2-input decode gating and spike-free decoded outputs. Anti-lock gating is provided, thus assuring proper counter sequence. The decoded output are normally low and go high only at their respective decoded time slot. Each decoded output remains high for one full clock cycle. A CARRY-OUT signal completes one cycle every 10 clock input cycles in the CD4017BMS or every 8 clock input cycles in the CD4022BMS and is used to ripple-clock the succeeding device in a multi-device counting chain.

The CD4017BMS and CD4022BMS series types are supplied in these 16 lead outline packages

Braze Seal DIP \*H4W †H4X

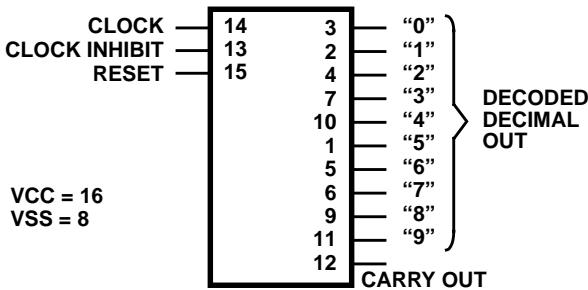
Frit Seal DIP \*H1F †H1E

Ceramic Flatpack H6W

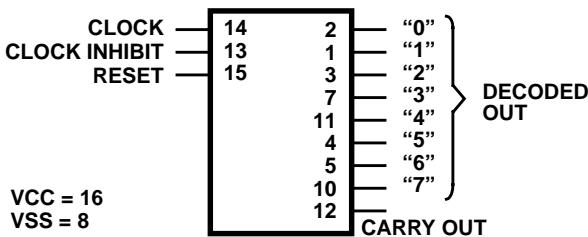
\*CD4017B Only † CD4022B Only

## Functional Diagrams

CD4017BMS



CD4022BMS



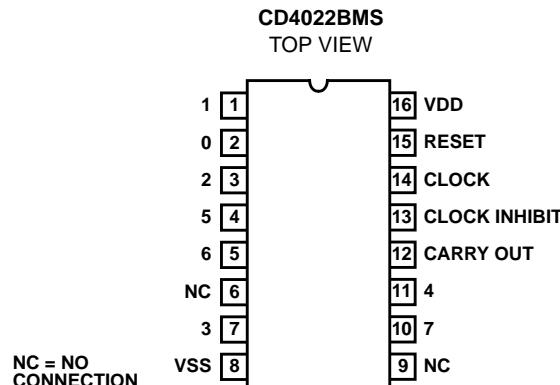
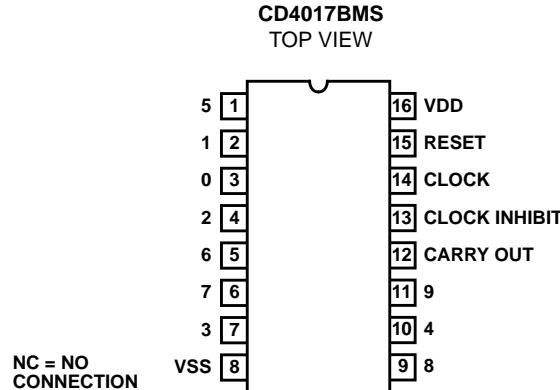
## Features

- High Voltage Types (20V Rating)
- Fully Static Operation
- Medium-Speed Operation 10MHz (Typ) at VDD = 10V
- Standardized Symmetrical Output Characteristics
- 100% Tested for Quiescent Current at 20V
- 5V, 10V and 15V Parametric Ratings
- Meets All Requirements of JEDEC Tentative Standard Number 13A, "Standard Specifications for Description of 'B' Series CMOS Devices"

## Applications

- Decade Counter/Decimal Decode Display (CD4017BMS)
- Binary Counter/Decoder
- Frequency Division
- Counter Control/Timers
- Divide-by-N Counting
- For Further Application Information, See ICAN-6166 "COS/MOS MSI Counter and Register Design and Applications"

## Pinouts



**Absolute Maximum Ratings**

|  |                    |
|--|--------------------|
| DC Supply Voltage Range, (VDD) . . . . .                                 | -0.5V to +20V      |
| (Voltage Referenced to VSS Terminals)                                    |                    |
| Input Voltage Range, All Inputs . . . . .                                | -0.5V to VDD +0.5V |
| DC Input Current, Any One Input . . . . .                                | $\pm 10\text{mA}$  |
| Operating Temperature Range . . . . .                                    | -55°C to +125°C    |
| Package Types D, F, K, H   |                    |
| Storage Temperature Range (TSTG) . . . . .                               | -65°C to +150°C    |
| Lead Temperature (During Soldering) . . . . .                            | +265°C             |
| At Distance 1/16 ± 1/32 Inch (1.59mm ± 0.79mm) from case for 10s Maximum |                    |

**Reliability Information**

|   |                                      |               |
|---|--------------------------------------|---------------|
| Thermal Resistance . . . . .                                | $\theta_{ja}$                        | $\theta_{jc}$ |
| Ceramic DIP and FRIT Package . . . . .                      | 80°C/W                               | 20°C/W        |
| Flatpack Package . . . . .                                  | 70°C/W                               | 20°C/W        |
| Maximum Package Power Dissipation (PD) at +125°C            |                                      |               |
| For TA = -55°C to +100°C (Package Type D, F, K) . . . . .   | .500mW                               |               |
| For TA = +100°C to +125°C (Package Type D, F, K) . . . . .  | Derate Linearity at 12mW/°C to 200mW |               |
| Device Dissipation per Output Transistor . . . . .          | .100mW                               |               |
| For TA = Full Package Temperature Range (All Package Types) |                                      |               |
| Junction Temperature . . . . .                              | +175°C                               |               |

TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

| PARAMETER                   | SYMBOL | CONDITIONS (NOTE 1)                | GROUP A SUBGROUPS | TEMPERATURE          | LIMITS      |             | UNITS |    |
|-----------------------------|--------|------------------------------------|-------------------|----------------------|-------------|-------------|-------|----|
|                             |        |                                    |                   |                      | MIN         | MAX         |       |    |
| Supply Current              | IDD    | VDD = 20V, VIN = VDD or GND        | 1                 | +25°C                | -           | 10          | µA    |    |
|                             |        |                                    | 2                 | +125°C               | -           | 1000        | µA    |    |
|                             |        | VDD = 18V, VIN = VDD or GND        | 3                 | -55°C                | -           | 10          | µA    |    |
| Input Leakage Current       | IIL    | VIN = VDD or GND                   | VDD = 20          | 1                    | +25°C       | -100        | nA    |    |
|                             |        |                                    |                   | 2                    | +125°C      | -1000       | nA    |    |
|                             |        | VDD = 18V                          | 3                 | -55°C                | -100        | -           | nA    |    |
| Input Leakage Current       | IIH    | VIN = VDD or GND                   | VDD = 20          | 1                    | +25°C       | -           | 100   | nA |
|                             |        |                                    |                   | 2                    | +125°C      | -           | 1000  | nA |
|                             |        | VDD = 18V                          | 3                 | -55°C                | -           | 100         | nA    |    |
| Output Voltage              | VOL15  | VDD = 15V, No Load                 | 1, 2, 3           | +25°C, +125°C, -55°C | -           | 50          | mV    |    |
| Output Voltage              | VOH15  | VDD = 15V, No Load (Note 3)        | 1, 2, 3           | +25°C, +125°C, -55°C | 14.95       | -           | V     |    |
| Output Current (Sink)       | IOL5   | VDD = 5V, VOUT = 0.4V              | 1                 | +25°C                | 0.53        | -           | mA    |    |
| Output Current (Sink)       | IOL10  | VDD = 10V, VOUT = 0.5V             | 1                 | +25°C                | 1.4         | -           | mA    |    |
| Output Current (Sink)       | IOL15  | VDD = 15V, VOUT = 1.5V             | 1                 | +25°C                | 3.5         | -           | mA    |    |
| Output Current (Source)     | IOH5A  | VDD = 5V, VOUT = 4.6V              | 1                 | +25°C                | -           | -0.53       | mA    |    |
| Output Current (Source)     | IOH5B  | VDD = 5V, VOUT = 2.5V              | 1                 | +25°C                | -           | -1.8        | mA    |    |
| Output Current (Source)     | IOH10  | VDD = 10V, VOUT = 9.5V             | 1                 | +25°C                | -           | -1.4        | mA    |    |
| Output Current (Source)     | IOH15  | VDD = 15V, VOUT = 13.5V            | 1                 | +25°C                | -           | -3.5        | mA    |    |
| N Threshold Voltage         | VNTH   | VDD = 10V, ISS = -10µA             | 1                 | +25°C                | -2.8        | -0.7        | V     |    |
| P Threshold Voltage         | VPTH   | VSS = 0V, IDD = 10µA               | 1                 | +25°C                | 0.7         | 2.8         | V     |    |
| Functional                  | F      | VDD = 2.8V, VIN = VDD or GND       | 7                 | +25°C                | VOH > VDD/2 | VOL < VDD/2 | V     |    |
|                             |        | VDD = 20V, VIN = VDD or GND        | 7                 | +25°C                |             |             |       |    |
|                             |        | VDD = 18V, VIN = VDD or GND        | 8A                | +125°C               |             |             |       |    |
|                             |        | VDD = 3V, VIN = VDD or GND         | 8B                | -55°C                |             |             |       |    |
| Input Voltage Low (Note 2)  | VIL    | VDD = 5V, VOH > 4.5V, VOL < 0.5V   | 1, 2, 3           | +25°C, +125°C, -55°C | -           | 1.5         | V     |    |
| Input Voltage High (Note 2) | VIH    | VDD = 5V, VOH > 4.5V, VOL < 0.5V   | 1, 2, 3           | +25°C, +125°C, -55°C | 3.5         | -           | V     |    |
| Input Voltage Low (Note 2)  | VIL    | VDD = 15V, VOH > 13.5V, VOL < 1.5V | 1, 2, 3           | +25°C, +125°C, -55°C | -           | 4           | V     |    |
| Input Voltage High (Note 2) | VIH    | VDD = 15V, VOH > 13.5V, VOL < 1.5V | 1, 2, 3           | +25°C, +125°C, -55°C | 11          | -           | V     |    |

NOTES: 1. All voltages referenced to device GND, 100% testing being implemented.

3. For accuracy, voltage is measured differentially to VDD. Limit is 0.050V max.

2. Go/No Go test with limits applied to inputs

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**TABLE 2. AC ELECTRICAL PERFORMANCE CHARACTERISTICS**

| PARAMETER                                | SYMBOL         | CONDITIONS (Note 1, 2)     | GROUP A<br>SUBGROUPS | TEMPERATURE   | LIMITS |     | UNITS |
|--|----------------|----------------------------|----------------------|---------------|--------|-----|-------|
|  |                |                            |                      |               | MIN    | MAX |       |
| Propagation Delay<br>Clock to Decode Out | TPHL1<br>TPLH1 | VDD = 5V, VIN = VDD or GND | 9                    | +25°C         | -      | 650 | ns    |
|  |                |                            | 10, 11               | +125°C, -55°C | -      | 878 | ns    |
| Propagation Delay<br>Clock to Carry Out  | TPHL2<br>TPLH2 | VDD = 5V, VIN = VDD or GND | 9                    | +25°C         | -      | 600 | ns    |
|  |                |                            | 10, 11               | +125°C, -55°C | -      | 810 | ns    |
| Propagation Delay<br>Reset to Out        | TPHL3<br>TPLH3 | VDD = 5V, VIN = VDD or GND | 9                    | +25°C         | -      | 530 | ns    |
|  |                |                            | 10, 11               | +125°C, -55°C | -      | 716 | ns    |
| Transition Time                          | TTHL<br>TTLH   | VDD = 5V, VIN = VDD or GND | 9                    | +25°C         | -      | 200 | ns    |
|  |                |                            | 10, 11               | +125°C, -55°C | -      | 270 | ns    |
| Maximum Clock Input Frequency            | FCL            | VDD = 5V, VIN = VDD or GND | 9                    | +25°C         | 2.5    | -   | MHz   |
|  |                |                            | 10, 11               | +125°C, -55°C | 1.85   | -   | MHz   |

NOTES:

1. CL = 50pF, RL = 200K, Input TR, TF < 20ns.
2. -55°C and +125°C limits guaranteed, 100% testing being implemented.

**TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS**

| PARAMETER               | SYMBOL | CONDITIONS                    | NOTES | TEMPERATURE          | LIMITS |       | UNITS |
|-------------------------|--------|-------------------------------|-------|----------------------|--------|-------|-------|
|                         |        |                               |       |                      | MIN    | MAX   |       |
| Supply Current          | IDD    | VDD = 5V, VIN = VDD or GND    | 1, 2  | -55°C, +25°C         | -      | 5     | µA    |
|                         |        |                               |       | +125°C               | -      | 150   | µA    |
|                         |        | VDD = 10V, VIN = VDD or GND   | 1, 2  | -55°C, +25°C         | -      | 10    | µA    |
|                         |        |                               |       | +125°C               | -      | 300   | µA    |
|                         |        | VDD = 15V, VIN = VDD or GND   | 1, 2  | -55°C, +25°C         | -      | 10    | µA    |
|                         |        |                               |       | +125°C               | -      | 600   | µA    |
| Output Voltage          | VOL    | VDD = 5V, No Load             | 1, 2  | +25°C, +125°C, -55°C | -      | 50    | mV    |
| Output Voltage          | VOL    | VDD = 10V, No Load            | 1, 2  | +25°C, +125°C, -55°C | -      | 50    | mV    |
| Output Voltage          | VOH    | VDD = 5V, No Load             | 1, 2  | +25°C, +125°C, -55°C | 4.95   | -     | V     |
| Output Voltage          | VOH    | VDD = 10V, No Load            | 1, 2  | +25°C, +125°C, -55°C | 9.95   | -     | V     |
| Output Current (Sink)   | IOL5   | VDD = 5V, VOUT = 0.4V         | 1, 2  | +125°C               | 0.36   | -     | mA    |
| Output Current (Sink)   | IOL5   | +55°C                         | 0.64  | -                    | -      | mA    |       |
| Output Current (Sink)   | IOL10  | VDD = 10V, VOUT = 0.5V        | 1, 2  | +125°C               | 0.9    | -     | mA    |
| Output Current (Sink)   | IOL10  | +55°C                         | 1.6   | -                    | -      | mA    |       |
| Output Current (Sink)   | IOL15  | VDD = 15V, VOUT = 1.5V        | 1, 2  | +125°C               | 2.4    | -     | mA    |
| Output Current (Sink)   | IOL15  | +55°C                         | 4.2   | -                    | -      | mA    |       |
| Output Current (Source) | IOH5A  | VDD = 5V, VOUT = 4.6V         | 1, 2  | +125°C               | -      | -0.36 | mA    |
| Output Current (Source) | IOH5A  | +55°C                         | -0.64 | -                    | -      | mA    |       |
| Output Current (Source) | IOH5B  | VDD = 5V, VOUT = 2.5V         | 1, 2  | +125°C               | -      | -1.15 | mA    |
| Output Current (Source) | IOH5B  | +55°C                         | -2.0  | -                    | -      | mA    |       |
| Output Current (Source) | IOH10  | VDD = 10V, VOUT = 9.5V        | 1, 2  | +125°C               | -      | -0.9  | mA    |
| Output Current (Source) | IOH10  | +55°C                         | -1.6  | -                    | -      | mA    |       |
| Output Current (Source) | IOH15  | VDD = 15V, VOUT = 13.5V       | 1, 2  | +125°C               | -      | -2.4  | mA    |
| Output Current (Source) | IOH15  | +55°C                         | -4.2  | -                    | -      | mA    |       |
| Input Voltage Low       | VIL    | VDD = 10V, VOH > 9V, VOL < 1V | 1, 2  | +25°C, +125°C, -55°C | -      | 3     | V     |
| Input Voltage High      | VIH    | VDD = 10V, VOH > 9V, VOL < 1V | 1, 2  | +25°C, +125°C, -55°C | 7      | -     | V     |

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**TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS (Continued)**

| PARAMETER                                       | SYMBOL         | CONDITIONS | NOTES   | TEMPERATURE | LIMITS |     | UNITS |
|---|----------------|------------|---------|-------------|--------|-----|-------|
|   |                |            |         |             | MIN    | MAX |       |
| Propagation Delay Clock to Decode Out           | TPHL1<br>TPLH1 | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 270 | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 170 | ns    |
| Propagation Delay Clock to Carry Out            | TPHL2<br>TPLH2 | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 250 | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 160 | ns    |
| Propagation Delay Reset to out                  | TPHL3<br>TPLH3 | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 230 | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 170 | ns    |
| Transition Time                                 | TTHL<br>TTLH   | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 100 | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 80  | ns    |
| Maximum Clock Input Frequency                   | FCL            | VDD = 10V  | 1, 2, 3 | +25°C       | 5.0    | -   | MHz   |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | 5.5    | -   | MHz   |
| Minimum Setup Time Clock Inhibit to Clock Setup | TS             | VDD = 5V   | 1, 2, 3 | +25°C       | -      | 230 | ns    |
|   |                | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 100 | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 70  | ns    |
| Minimum Reset Pulse Width                       | TW             | VDD = 5V   | 1, 2, 3 | +25°C       | -      | 260 | ns    |
|   |                | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 110 | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 60  | ns    |
| Minimum Clock Pulse Width                       | TW             | VDD = 5V   | 1, 2, 3 | +25°C       | -      | 200 | ns    |
|   |                | VDD = 10V  | 1, 2, 3 | +25°C       | -      | 90  | ns    |
|   |                | VDD = 15V  | 1, 2, 3 | +25°C       | -      | 60  | ns    |
| Input Capacitance                               | CIN            | Any Input  | 1, 2    | +25°C       | -      | 7.5 | pF    |

NOTES:

1. All voltages referenced to device GND.
2. The parameters listed on Table 3 are controlled via design or process and are not directly tested. These parameters are characterized on initial design release and upon design changes which would affect these characteristics.
3. CL = 50pF, RL = 200K, Input TR, TF < 20ns.

**TABLE 4. POST IRRADIATION ELECTRICAL PERFORMANCE CHARACTERISTICS**

| PARAMETER                 | SYMBOL       | CONDITIONS  | NOTES      | TEMPERATURE | LIMITS         |                          | UNITS |
|---------------------------|--------------|---|------------|-------------|----------------|--------------------------|-------|
|                           |              |   |            |             | MIN            | MAX                      |       |
| Supply Current            | IDD          | VDD = 20V, VIN = VDD or GND                               | 1, 4       | +25°C       | -              | 25                       | µA    |
| N Threshold Voltage       | VTN          | VDD = 10V, ISS = -10µA                                    | 1, 4       | +25°C       | -2.8           | -0.7                     | V     |
| N Threshold Voltage Delta | ΔVTN         | VDD = 10V, ISS = -10µA                                    | 1, 4       | +25°C       | -              | ±1                       | V     |
| P Threshold Voltage       | VTP          | VSS = 0V, IDD = 10µA                                      | 1, 4       | +25°C       | 0.2            | 2.8                      | V     |
| P Threshold Voltage Delta | ΔVTP         | VSS = 0V, IDD = 10µA                                      | 1, 4       | +25°C       | -              | ±1                       | V     |
| Functional                | F            | VDD = 18V, VIN = VDD or GND<br>VDD = 3V, VIN = VDD or GND | 1          | +25°C       | VOH ><br>VDD/2 | VOL <<br>VDD/2           | V     |
| Propagation Delay Time    | TPHL<br>TPLH | VDD = 5V  | 1, 2, 3, 4 | +25°C       | -              | 1.35 x<br>+25°C<br>Limit | ns    |

NOTES: 1. All voltages referenced to device GND.

3. See Table 2 for +25°C limit.

2. CL = 50pF, RL = 200K, Input TR, TF < 20ns.

4. Read and Record

**TABLE 5. BURN-IN AND LIFE TEST DELTA PARAMETERS +25°C**

| PARAMETER               | SYMBOL | DELTA LIMIT              |
|-------------------------|--------|--------------------------|
| Supply Current - MSI-2  | IDD    | ± 1.0µA                  |
| Output Current (Sink)   | IOL5   | ± 20% x Pre-Test Reading |
| Output Current (Source) | IOH5A  | ± 20% x Pre-Test Reading |

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**TABLE 6. APPLICABLE SUBGROUPS**

| CONFORMANCE GROUP             | MIL-STD-883 METHOD | GROUP A SUBGROUPS             | READ AND RECORD                       |
|-------------------------------|--------------------|-------------------------------|---------------------------------------|
| Initial Test (Pre Burn-In)    | 100% 5004          | 1, 7, 9                       | IDD, IOL5, IOH5A                      |
| Interim Test 1 (Post Burn-In) | 100% 5004          | 1, 7, 9                       | IDD, IOL5, IOH5A                      |
| Interim Test 2 (Post Burn-In) | 100% 5004          | 1, 7, 9                       | IDD, IOL5, IOH5A                      |
| PDA (Note 1)                  | 100% 5004          | 1, 7, 9, Deltas               |                                       |
| Interim Test 3 (Post Burn-In) | 100% 5004          | 1, 7, 9                       | IDD, IOL5, IOH5A                      |
| PDA (Note 1)                  | 100% 5004          | 1, 7, 9, Deltas               |                                       |
| Final Test                    | 100% 5004          | 2, 3, 8A, 8B, 10, 11          |                                       |
| Group A                       | Sample 5005        | 1, 2, 3, 7, 8A, 8B, 9, 10, 11 |                                       |
| Group B                       | Subgroup B-5       | Sample 5005                   | 1, 2, 3, 7, 8A, 8B, 9, 10, 11, Deltas |
|                               | Subgroup B-6       | Sample 5005                   | 1, 7, 9                               |
| Group D                       | Sample 5005        | 1, 2, 3, 8A, 8B, 9            | Subgroups 1, 2 3                      |

NOTE: 1. 5% Parameteric, 3% Functional; Cumulative for Static 1 and 2.

**TABLE 7. TOTAL DOSE IRRADIATION**

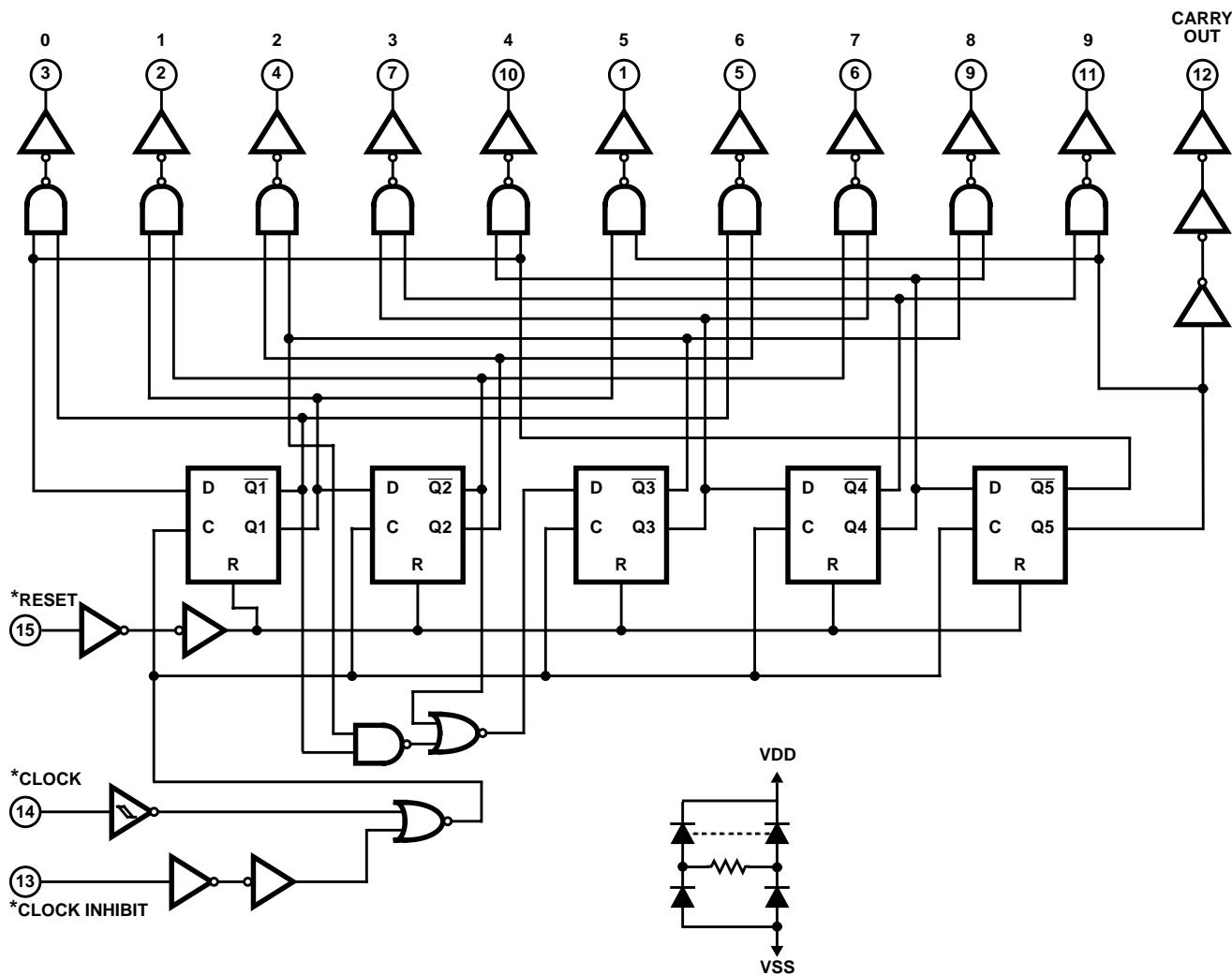
| CONFORMANCE GROUPS | MIL-STD-883 METHOD | TEST      |            | READ AND RECORD |            |
|--------------------|--------------------|-----------|------------|-----------------|------------|
|                    |                    | PRE-IRRAD | POST-IRRAD | PRE-IRRAD       | POST-IRRAD |
| Group E Subgroup 2 | 5005               | 1, 7, 9   | Table 4    | 1, 9            | Table 4    |

**TABLE 8. BURN-IN AND IRRADIATION TEST CONNECTIONS**

| FUNCTION                                 | OPEN          | GROUND    | VDD        | 9V ± -0.5V    | OSCILLATOR |       |
|--|---------------|-----------|------------|---------------|------------|-------|
|  |               |           |            |               | 50kHz      | 25kHz |
| <b>PART NUMBER CD4017BMS AND CD4002B</b> |               |           |            |               |            |       |
| Static Burn-In 1<br>Note 1               | 1 - 7, 9 - 12 | 8, 13, 15 | 14, 16     | -             | -          | -     |
| Static Burn-In 2<br>Note 1               | 1 - 7, 9 - 12 | 8, 14     | 13, 15, 16 | -             | -          | -     |
| Dynamic Burn-In Note 1                   | -             | 8, 13, 15 | 16         | 1 - 7, 9 - 12 | 14         | -     |
| Irradiation<br>Note 2                    | 1 - 7, 9 - 12 | 8         | 13 - 16    | -             | -          | -     |

NOTE:

1. Each pin except VDD and GND will have a series resistor of  $10K \pm 5\%$ , VDD =  $18V \pm 0.5V$
2. Each pin except VDD and GND will have a series resistor of  $47K \pm 5\%$ ; Group E, Subgroup 2, sample size is 4 dice/wafer, 0 failures, VDD =  $10V \pm 0.5V$

**Logic Diagram**

\* All Inputs Protected by CMOS Protection Network

FIGURE 1. CD4017BMS

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**Logic Diagram (Continued)**

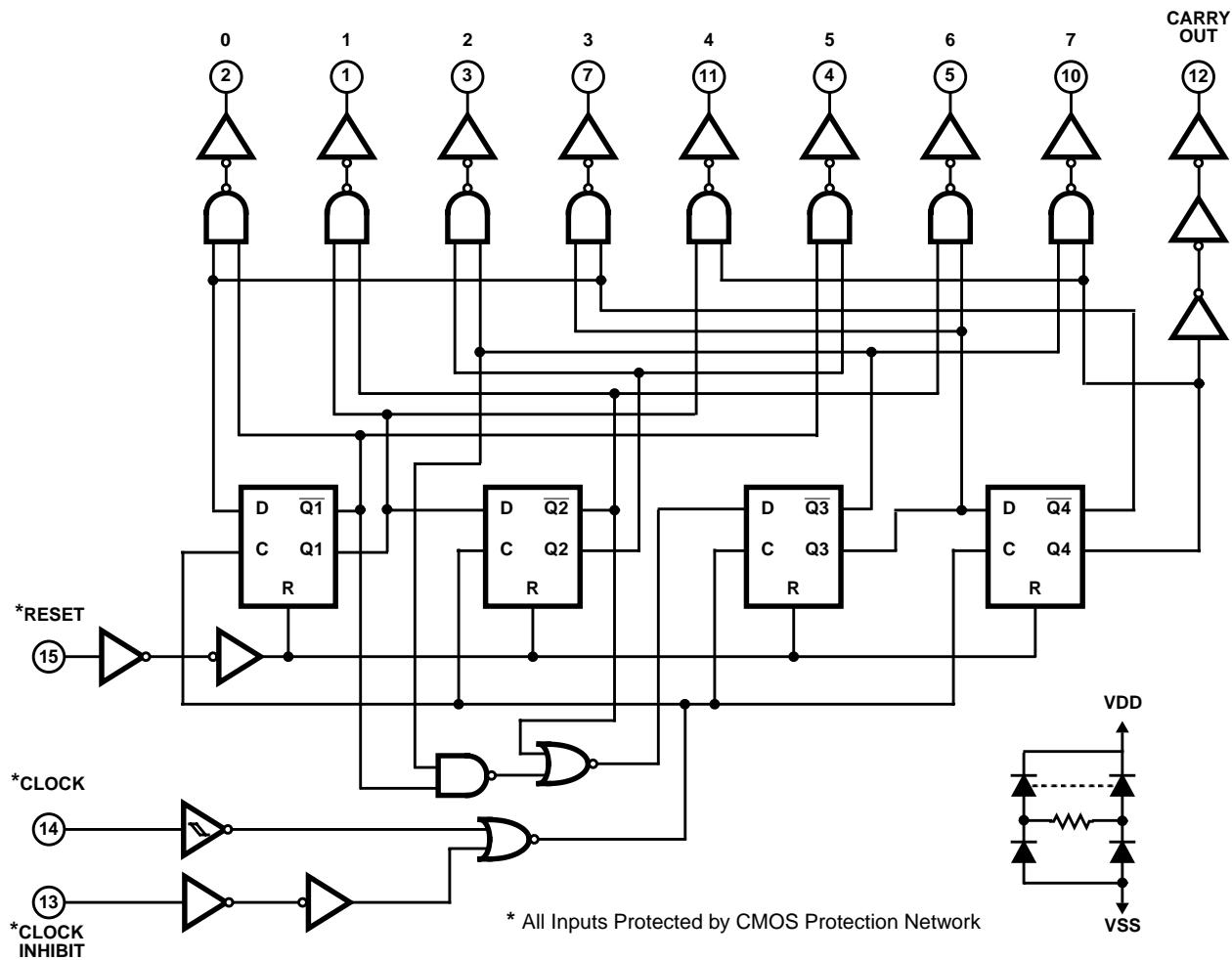


FIGURE 2. CD4022BMS

**Timing Diagram**

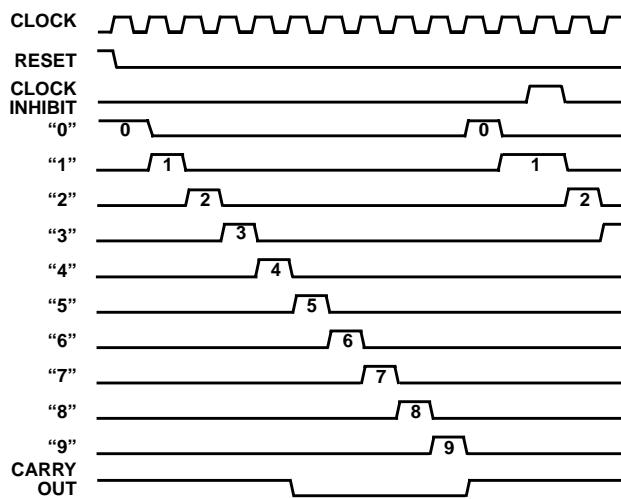


FIGURE 3. CD4017BMS

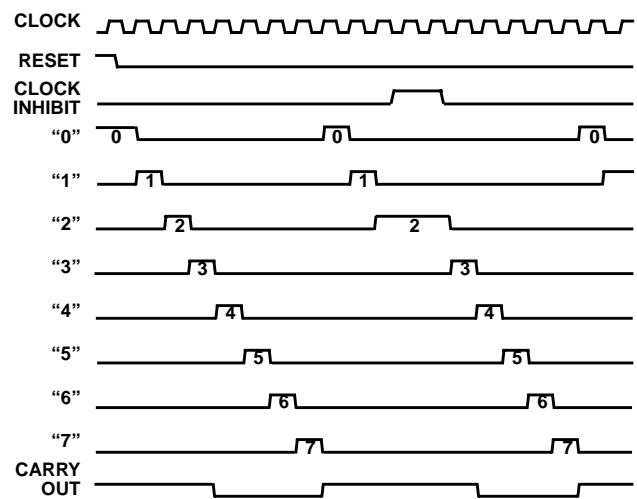


FIGURE4. CD4022BMS

### Typical Performance Characteristics

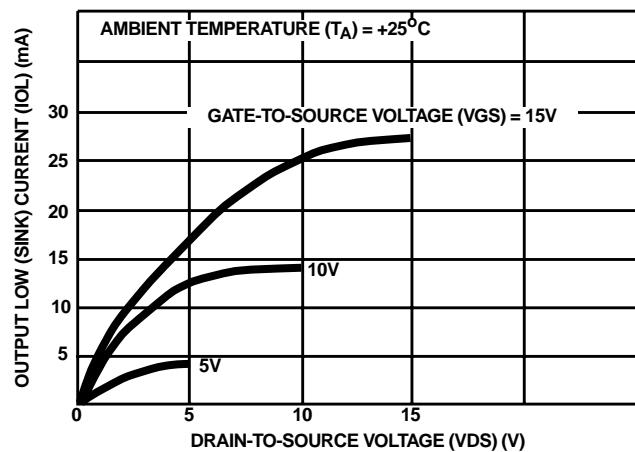


FIGURE 5. TYPICAL OUTPUT LOW (SINK) CURRENT CHARACTERISTICS

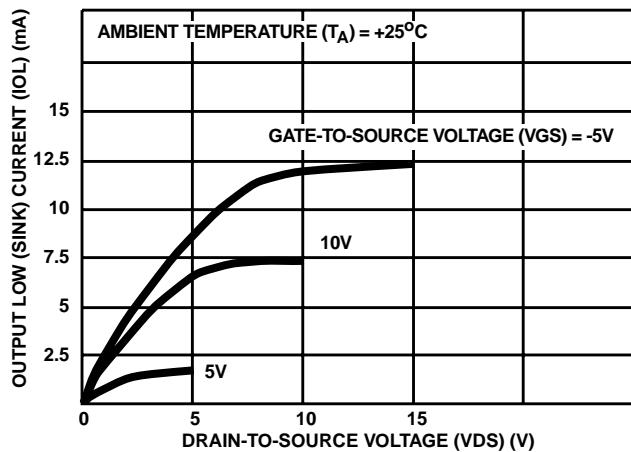


FIGURE 6. MINIMUM OUTPUT LOW (SINK) CURRENT CHARACTERISTICS

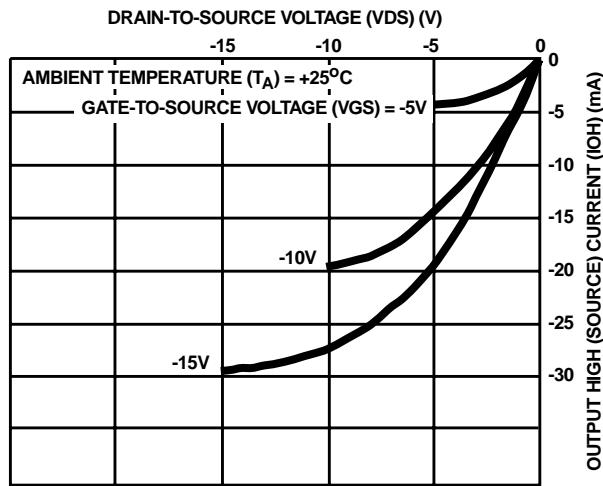


FIGURE 7. TYPICAL OUTPUT HIGH (SOURCE) CURRENT CHARACTERISTICS

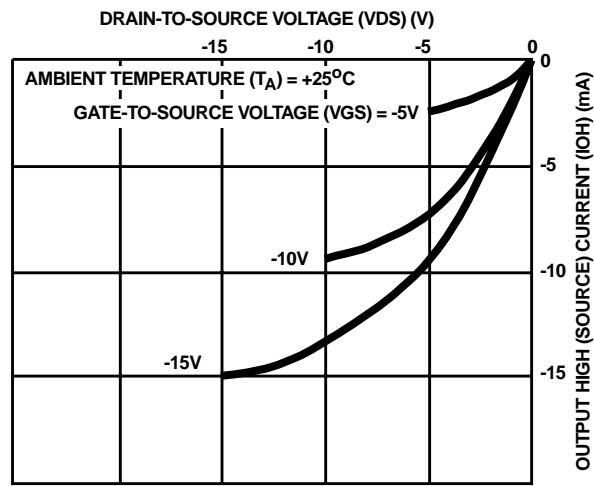


FIGURE 8. MINIMUM OUTPUT HIGH (SOURCE) CURRENT CHARACTERISTICS

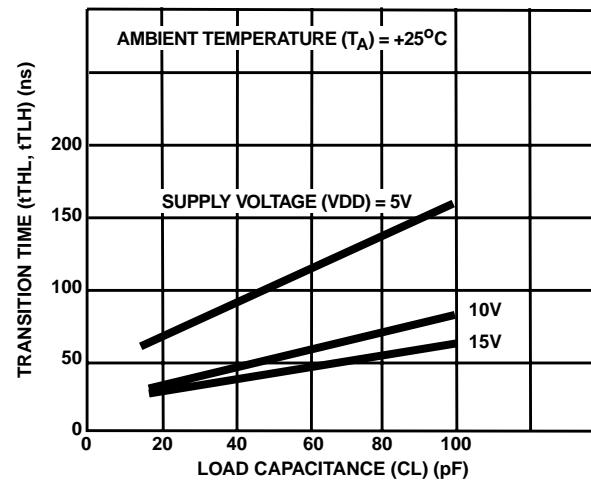


FIGURE 9. TYPICAL TRANSITION TIME AS A FUNCTION OF LOAD CAPACITANCE

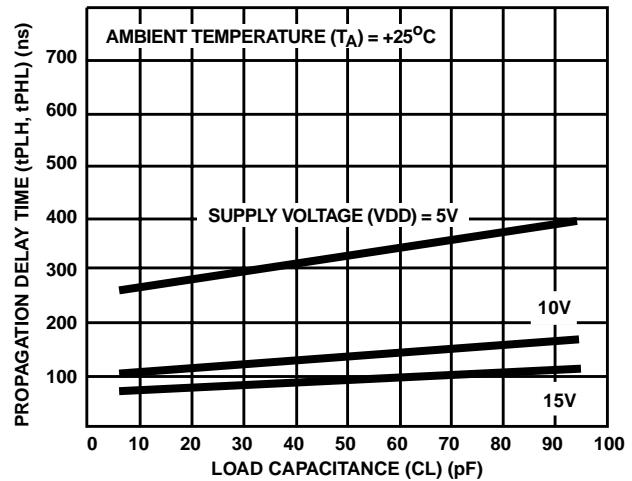


FIGURE 10. TYPICAL PROPAGATION DELAY TIME AS A FUNCTION OF LOAD CAPACITANCE (CLOCK TO DECODE OUTPUT)

**Typical Performance Characteristics (Continued)**

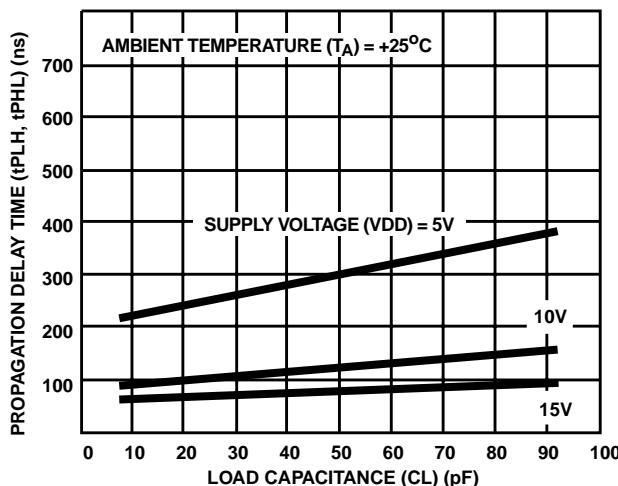


FIGURE 11. TYPICAL PROPAGATION DELAY TIME AS A FUNCTION OF LOAD CAPACITANCE (CLOCK TO CARRY OUT)

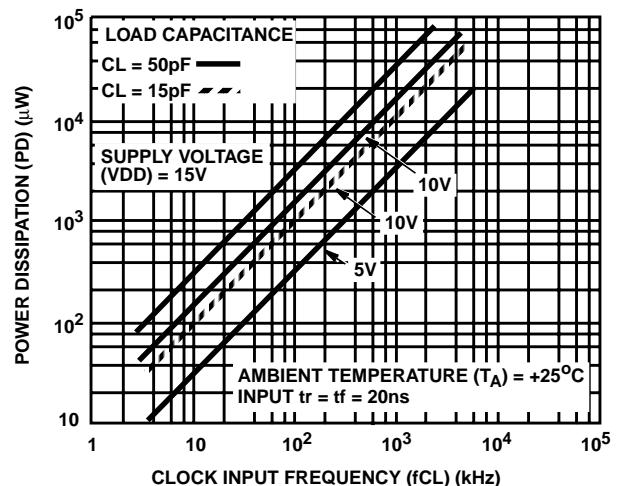


FIGURE 12. TYPICAL DYNAMIC POWER DISSIPATION AS A FUNCTION OF CLOCK INPUT FREQUENCY

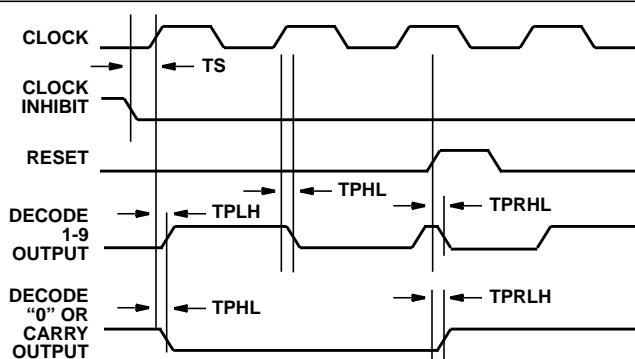


FIGURE 13. PROPAGATION DELAY, SETUP, AND RESET REMOVAL TIME WAVEFORMS

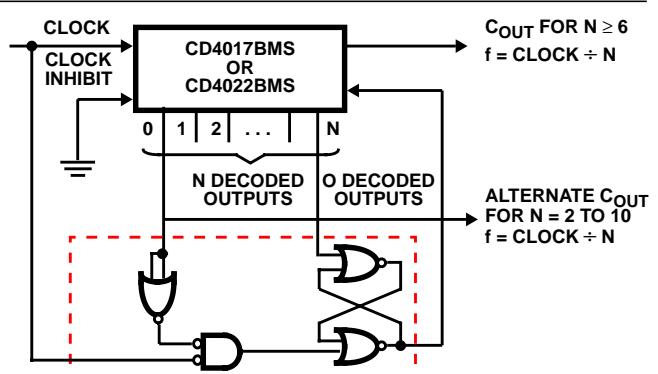


FIGURE 14. DIVIDE BY N COUNTER ( $N \leq 10$ ) WITH  $N$  DECODED OUTPUTS

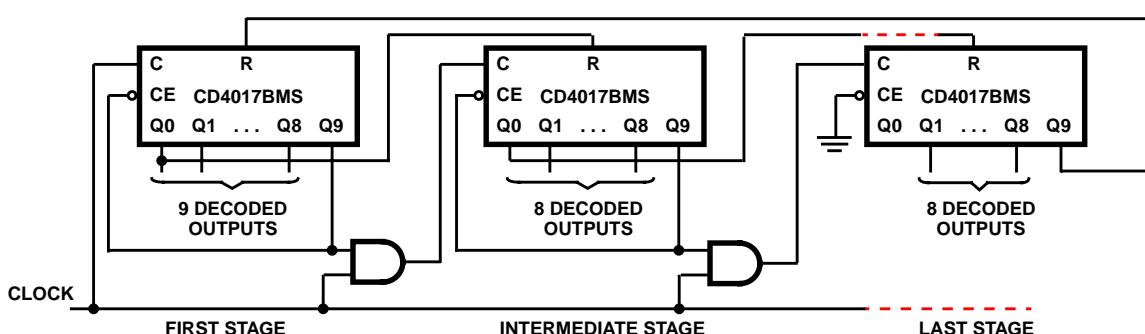
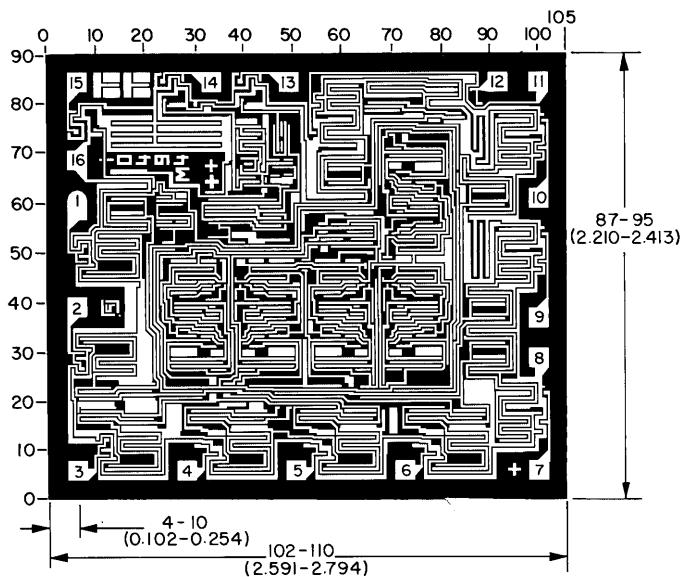


FIGURE 15. CASCADING THE CD4017BMS

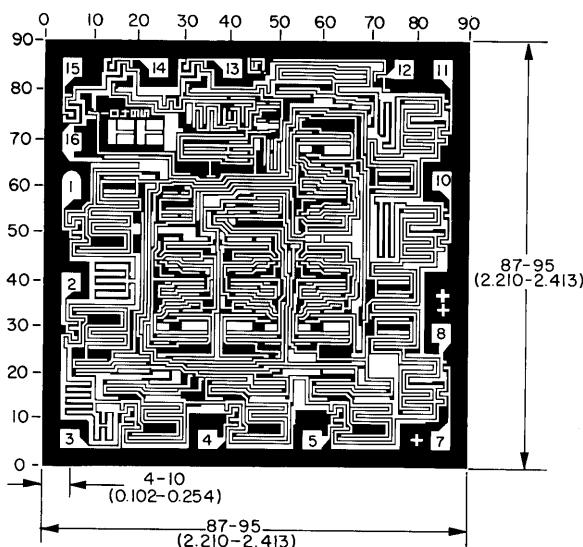
When the  $N^{\text{th}}$  decoded output is reached ( $N^{\text{th}}$  clock pulse) the S-R flip-flop (constructed from two NOR gates of the CD4001B) generates a reset pulse which clears the CD4017BMS or CD4022BMS to its zero count. At this time, if the  $N^{\text{th}}$  decoded output is greater than or equal to 6 in the CD4017BMS or 5 in the CD4022BMS, the  $C_{OUT}$  line goes high to clock the next CD4017BMS or CD4022BMS counter section. The "0"

decoded output also goes high at this time. Coincidence of the clock low and decoded "0" output low resets the S-R flip-flop to enable the CD4017BMS or CD4022BMS. If the  $N^{\text{th}}$  decoded output is less than 6 (CD4017BMS) or 5 (CD4022BMS), the  $C_{OUT}$  line will not go high and, therefore, cannot be used. In this case "0" decoded output may be used to perform the clocking function for the next counter.

**Chip Dimensions and Pad Layouts**



**CD4017BMSH**



Dimensions in parentheses are in millimeters  
and are derived from the basic inch dimensions  
as indicated. Grid graduations are in mils ( $10^{-3}$  inch)

**CD4022BMSH**

**METALLIZATION:** Thickness:  $11\text{k}\text{\AA}$  -  $14\text{k}\text{\AA}$ , AL.

**PASSIVATION:**  $10.4\text{k}\text{\AA}$  -  $15.6\text{k}\text{\AA}$ , Silane

**BOND PADS:** 0.004 inches X 0.004 inches MIN

**DIE THICKNESS:** 0.0198 inches - 0.0218